

AO4850

Dual N-Channel Enhancement Mode Field Effect Transistor



General Description

The AO4850 uses advanced trench technology to provide excellent $R_{\rm DS(ON)}$ and low gate charge. The two MOSFETs may be used in H-bridge, Inverters and other applications. AO4850 is Pb-free (meets ROHS & Sony 259 specifications).

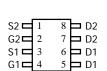
Features

 $V_{DS}(V) = 75V$

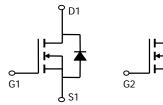
 $I_D = 3.1A$ ($V_{GS} = 10V$)

 $R_{DS(ON)}$ < 130m Ω (V_{GS} = 10V)

 $R_{DS(ON)} < 165 m\Omega (V_{GS} = 4.5 V)$







Absolute Maximum Ratings T_A=25°C unless otherwise noted

		Maximum				
Parameter		Symbol	10 Sec	Steady State	Units	
Drain-Source Voltage		V_{DS}	75		V	
Gate-Source Voltage		V_{GS}	±25		V	
Continuous Drain	T _A =25°C		3.1	2.3		
Current ^A	T _A =70°C	I _D	2.4	1.8	Α	
Pulsed Drain Current ^B		I _{DM}	15			
	T _A =25°C	В	2	1.1	W	
Power Dissipation	T _A =70°C	$-P_{D}$	1.3	0.7	VV	
Avalanche Current ^B		I _{AR}	10		Α	
Repetitive avalanche energy 0.3mH ^B		E _{AR}	15		mJ	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150		°C	

Thermal Characteristics							
Parameter		Symbol	Тур	Max	Units		
Maximum Junction-to-Ambient A	t ≤ 10s	В	50	62.5	°C/W		
Maximum Junction-to-Ambient A	Steady-State R _{0JA}		82	110	°C/W		
Maximum Junction-to-Lead ^C	Steady-State	$R_{ heta JL}$	41	50	°C/W		

Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter Conditions		Min	Тур	Max	Units			
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =10mA, V _{GS} =0V	75			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =75V, V _{GS} =0V			1	μА			
		Т _J =55°С			5	μ			
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±25V			100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=250\mu A$	1	2.3	3	V			
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V	15			Α			
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =3.1A		105	130	mΩ			
		T _J =125°C		158	195	11132			
		V_{GS} =4.5V, I_D =2A		126	165	mΩ			
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =3.1A		10		S			
V_{SD}	Diode Forward Voltage	$I_S=1A, V_{GS}=0V$		0.77	1	V			
I_S	Maximum Body-Diode Continuous Current				2.5	Α			
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance			290	380	pF			
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =30V, f=1MHz		54		pF			
C _{rss}	Reverse Transfer Capacitance			24		pF			
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		2.4	3.5	Ω			
SWITCHII	NG PARAMETERS								
Q _g (10V)	Total Gate Charge			5.14	7	nC			
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =30V, I _D =3.1A		2.34		nC			
Q_{gs}	Gate Source Charge	ν _{GS} -10ν, ν _{DS} -30ν, ι _D -3.1Α		0.97		nC			
Q_{gd}	Gate Drain Charge			1.18		nC			
t _{D(on)}	Turn-On DelayTime			4		ns			
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =30V, R_{L} =9.7 Ω ,		3.4		ns			
$t_{D(off)}$	Turn-Off DelayTime	R_{GEN} =3 Ω		14.4		ns			
t _f	Turn-Off Fall Time]		2.4		ns			
t _{rr}	Body Diode Reverse Recovery Time	I _F =3.1A, dI/dt=100A/μs		30.2	45	ns			
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =3.1A, dI/dt=100A/μs		21.5		nC			

A: The value of R $_{0,JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t ≤10s thermal resistance rating. B: Repetitive rating, pulse width limited by junction temperature.

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C. The R $_{\theta JA}$ is the sum of the thermal impedence from junction to lead R $_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T $_A$ =25°C. The SOA curve provides a single pulse rating.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

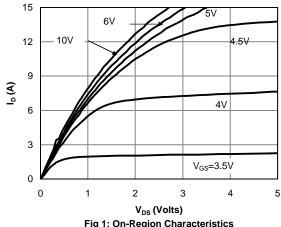


Fig 1: On-Region Characteristics

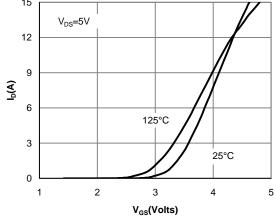


Figure 2: Transfer Characteristics

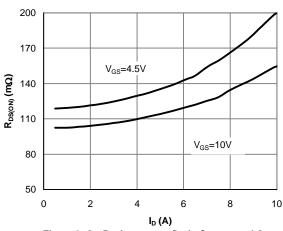


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

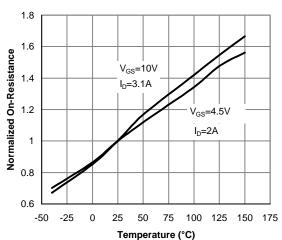


Figure 4: On-Resistance vs. Junction Temperature

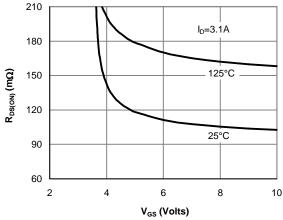


Figure 5: On-Resistance vs. Gate-Source Voltage

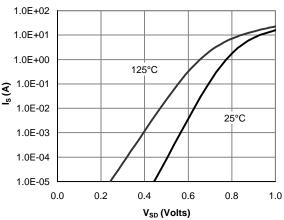


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

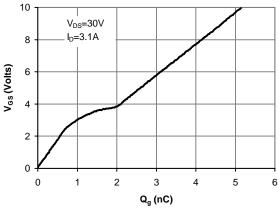


Figure 7: Gate-Charge Characteristics

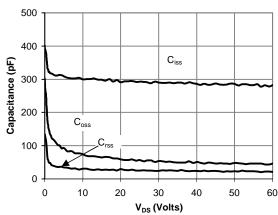


Figure 8: Capacitance Characteristics

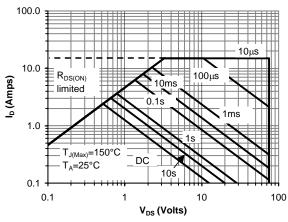


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

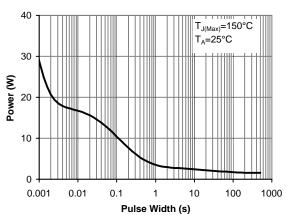


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

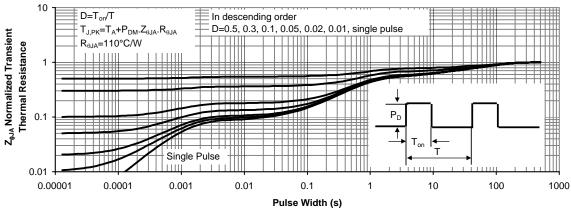


Figure 11: Normalized Maximum Transient Thermal Impedance